

<b>Notice of References Cited</b>	Application/Control No. 10/773,325	Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner PAUL T. CHIN	Art Unit 3652	Page 1 of 1

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*	C	US-5,391,050	02-1995	Gatteschi, Emanuele	414/796
*	D	US-6,334,641	01-2002	Oh, Tae Seok	294/119.1
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**NON-PATENT DOCUMENTS**

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